UTC UNISONIC TECHNOLOGIES CO., LTD

7N65Z **Power MOSFET**

7.4A, 650V N-CHANNEL **POWER MOSFET**

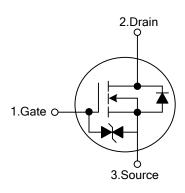
DESCRIPTION

The UTC 7N65Z is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)} = 1.2\Omega @V_{GS} = 10 V$
- * Ultra Low Gate Charge (Typical 29 nC)
- * Low Reverse Transfer Capacitance (C_{RSS} = typical 16pF)
- * Fast Switching Capability
- * Avalanche Energy Tested
- * Improved dv/dt Capability, High Ruggedness

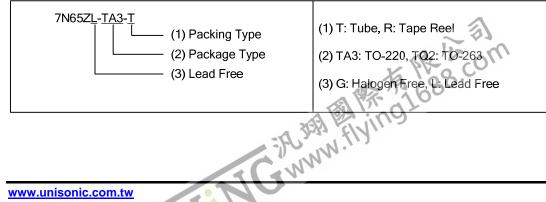
SYMBOL

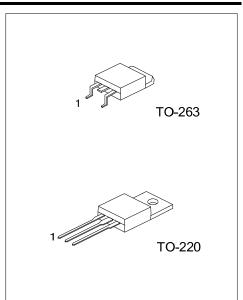


ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7N65ZL-TA3-T	7N65ZG-TA3-T	TO-220	G	D	S	Tube	
7N65ZL-TQ2-T	7N65ZG-TQ2-T	TO-263	G	D	S	Tube	
7N65ZL-TQ2-R	7N65ZG-TQ2-R	TO-263	G	D	S	Tape Reel	

Pin Assignment: G: Gate D: Drain S: Source





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■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	±30	V
Avalanche Current (Note 2)		I _{AR}	7.4	Α
Continuous Drain Current		I _D	7.4	Α
Pulsed Drain Current (Note 1)		I _{DM}	29.6	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	600	mJ
	Repetitive (Note 2)	E _{AR}	14.2	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Power Dissipation		P_D	142	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 19.5mH, I_{AS} = 7.4A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 7.4A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ_{JC}	0.88	°C/W	



ELECTRICAL CHARACTERISTICS (TC =25°C, unless otherwise specified)

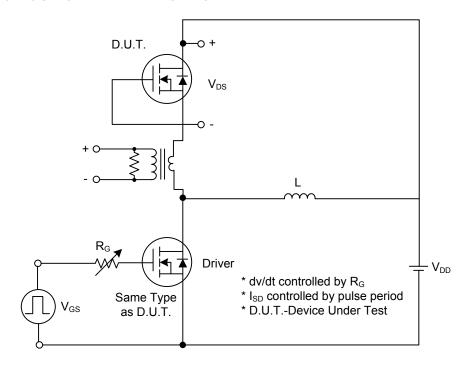
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS			,		1	I	
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} = 650V, V _{GS} = 0V			1	μA
Onto Common Londono Commont	Forward I _{GSS}	,	$V_{GS} = 30V, V_{DS} = 0V$			10	μΑ
Gate- Source Leakage Current		IGSS	$V_{GS} = -30V, V_{DS} = 0V$			-10	μΑ
Breakdown Voltage Temperature (Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA,Referenced to 25°C		0.67		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 3.7A$		0.94	1.2	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			1400	pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz			180	pF
Reverse Transfer Capacitance		C_{RSS}	1=1.0 IVIH2		16	21	pF
SWITCHING CHARACTERISTICS	3						
Turn-On Delay Time		$t_{D(ON)}$	V _{DD} =325V, I _D =7.4A,			70	ns
Turn-On Rise Time		t_R				170	ns
Turn-Off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)			140	ns
Turn-Off Fall Time		t_{F}				130	ns
Total Gate Charge		Q_G	\/ _F20\/ _7.4A		29	38	nC
Gate-Source Charge		Q_GS	V _{DS} =520V, I _D =7.4A,		7		nC
Gate-Drain Charge		Q_GD	V _{GS} =10 V (Note 1, 2)		14.5		nC
DRAIN-SOURCE DIODE CHARAG	CTERISTIC	CS AND MAX	IMUM RATINGS				
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS} = 0V, I_S = 7.4 A$			1.4	V
Maximum Continuous Drain-Source Diode		Is				7.4	^
Forward Current						7.4	Α
Maximum Pulsed Drain-Source Diode		I _{SM}				29.6	Α
Forward Current						29.0	А
Reverse Recovery Time		t _{rr}	$V_{GS} = 0V, I_S = 7.4A,$		320		ns
Reverse Recovery Charge		Q_{RR}	dI_F / $dt = 100A/\mu s$ (Note 1)		2.4		μC

Notes: 1. Pulse Test: Pulse width≤ 300µs, Duty cycle ≤ 2%

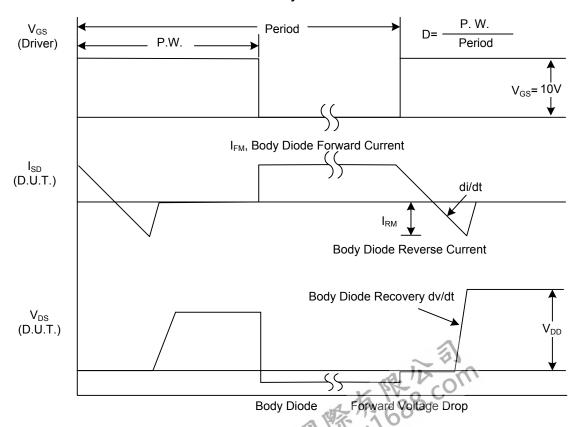
2. Essentially independent of operating temperature



■ TEST CIRCUITS AND WAVEFORMS

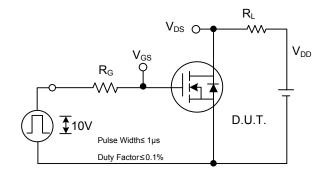


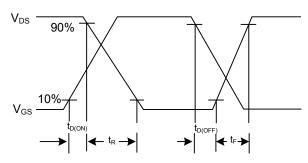
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

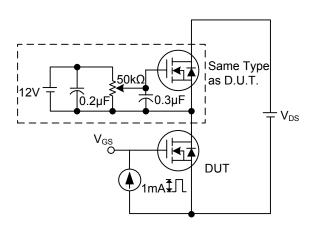
TEST CIRCUITS AND WAVEFORMS (Cont.)

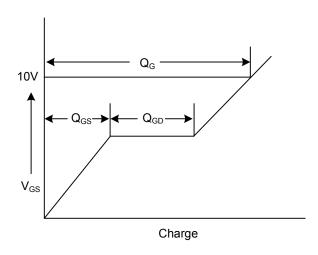




Switching Test Circuit

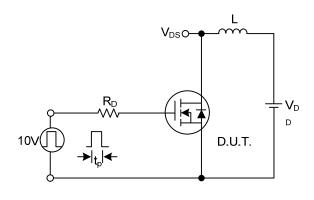
Switching Waveforms

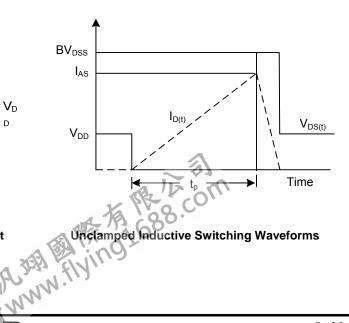




Gate Charge Test Circuit

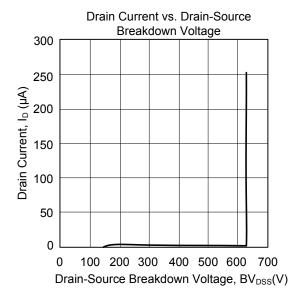
Gate Charge Waveform

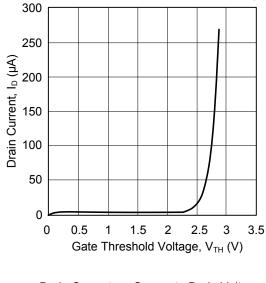




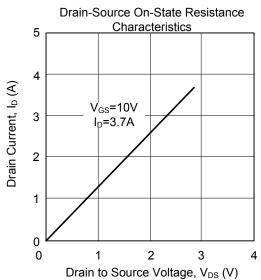
Unclamped Inductive Switching Test Circuit

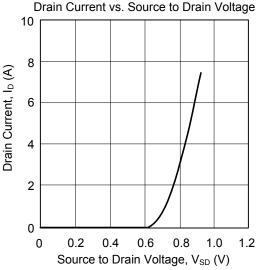
■ TYPICAL CHARACTERISTICS





Drain Current vs. Gate Threshold Voltage





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